## **Supporting Information**

## Impact of the Gas-Liquid interface on Photochemical Vapor Generation

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## **Table of Contents**

Figure S1. Time-resolved profiles of W, Ir, Se, Os, Sb, and Te in LS-FI-PVG and AS-FI-PVG
systems S3
Figure S2. Effect of the volume of the air segment on Hg, Fe, Co, Tl, and Ni detectionS4
Figure S3. Effect of the air/Ar slug(s) on As, Sn, Ir, Os, Cd, Ni, Hg, and Mo detectionS5
Figure S4. Effect of the concentration of H <sub>2</sub> O <sub>2</sub> on Sn detectionS6
Figure S5. EPR results for Sn PVG medium in LS-FI-PVG systemS7
Figure S6. Effect of the internal temperature of PVG reactor on Sn, As, Cd, and Mo detection-
S8
Figure S7. Effect of the sample solution temperature on As and Sn detectionS9
Figure S8. Effect of the gas-liquid interfaces on As and Sn detectionS10
Figure S9. Effect of the Ar carrier gas flow rate on As and Sn detectionS11
Figure S10. Calibration curves established by LS-FI-PVG and AS(s)-FI-PVG methodsS12
Table S1. Precision obtained using peak area by LS-FI-PVG and AS(s)-FI-PVG methods-S13
Table S2. Interferences from coexisting ions obtained in AS(s)-FI-PVG systemS14

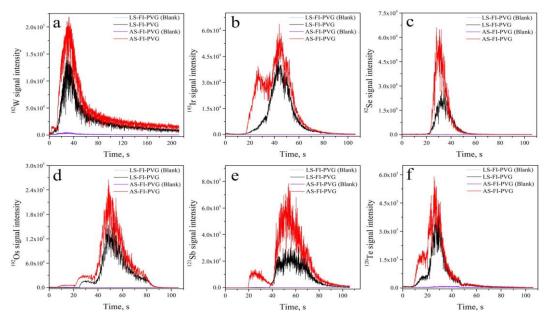


Figure S1. Time-resolved profiles of W, Ir, Se, Os, Sb, and Te in LS-FI-PVG, and AS-FI-PVG (air slug preceding the sample solution): a) 20 ng mL<sup>-1</sup> W, 40% (v/v) FA, 500 mg L<sup>-1</sup> Cd<sup>2+</sup>, 120 s UV irradiation time, and 2.24 mL of air slug; b) 2 ng mL<sup>-1</sup> Ir, 20% (v/v) FA; 25 mg L<sup>-1</sup> Cu<sup>2+</sup>, 45 s UV irradiation time, and 1.60 mL of air slug; c) 10 ng mL<sup>-1</sup> Se (IV), 15% (v/v) FA, 13 s UV irradiation time, and 2.88 mL of air slug; d) 5 ng mL<sup>-1</sup> Os, 5% (v/v) HNO<sub>3</sub>, 150 s UV irradiation time, and 0.77 mL of air slug; e) 10 ng mL<sup>-1</sup> Sb, 5% (v/v) FA, 20% (v/v) AA, 60 s UV irradiation time, and 2.24 mL of air slug; f) 10 ng mL<sup>-1</sup> Te, 2% (v/v) FA, 20% (v/v) FA, 20 mg L<sup>-1</sup> Fe<sup>2+</sup>, 5 g L<sup>-1</sup> nano-TiO<sub>2</sub>, 50 s UV irradiation time, and 1.28 mL of air slug.

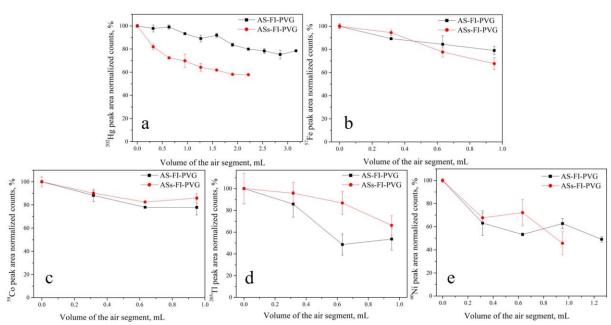


Figure S2. Effect of the volume of the air segment on  $^{202}$ Hg,  $^{57}$ Fe,  $^{59}$ Co,  $^{205}$ Tl and  $^{60}$ Ni responses: a) 10 ng mL $^{-1}$ Hg, 15% (v/v) FA, and 13 s UV irradiation time; b) 10 ng mL $^{-1}$ Fe, 60% (v/v) FA, and 180 s UV irradiation time; c) 10 ng mL $^{-1}$ Co, 50% (v/v) FA, and 180 s UV irradiation time; d) 20 ng mL $^{-1}$ Tl, 20% (v/v) FA, 20 mg L $^{-1}$ Co $^{2+}$  and 110 s UV irradiation time; e) 10 ng mL $^{-1}$ Ni, 50% (v/v) FA, and 180 s UV irradiation time.

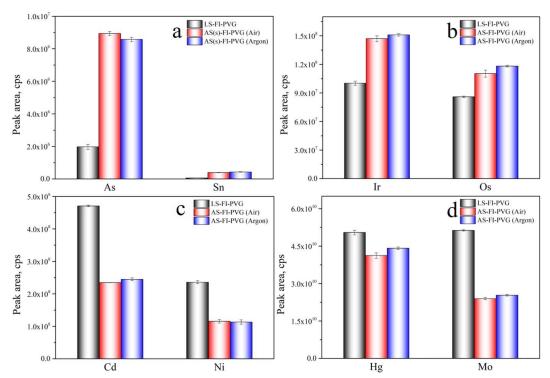


Figure S3. Effect of the air/Ar slugs on As, Sn, Ir, Os, Cd, Ni, Hg and Mo responses in AS(s)-FI-PVG system. a) As, 4% (v/v) FA, 20% (v/v) AA, 15 mg L<sup>-1</sup> Fe<sup>3+</sup>, 30 s irradiation, and 2.88 mL of air slug preceding the sample; Sn, 0.8% (v/v) AA, 0.01% (v/v) HCl, 32 s irradiation, and 1.60 mL of air slugs preceding and succeeding the sample; b) Ir, 20% (v/v) FA, 25 mg L<sup>-1</sup> Cu<sup>2+</sup>, 45 s UV irradiation time, and 1.60 mL of air slug preceding the sample; Os, 5% (v/v) HNO<sub>3</sub>, 150 s UV irradiation time, and 0.77 mL of air slug preceding the sample; c) Cd, 40% (v/v) FA, 30 mg L<sup>-1</sup> Co<sup>2+</sup>, 80 s UV irradiation time, and 1.28 mL of air slug preceding the sample; Ni, 50% (v/v) FA, 180 s UV irradiation time, and 1.28 mL of air slug preceding the sample; d) Hg, 15% (v/v) FA, and 13 s UV irradiation time, and 3.20 mL of air slug preceding the sample; Mo, 20% (v/v) FA, 20 mg L<sup>-1</sup> Co<sup>2+</sup>, 2.5 mg L<sup>-1</sup> Cu<sup>2+</sup>, and 60 s UV irradiation time, and 1.28 mL of air slug preceding the sample.

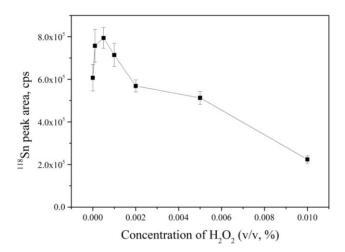


Figure S4. Effect of the concentration of  $H_2O_2$  on  $^{118}Sn$  response with 32 s UV irradiation in the absence of gas-liquid interface.

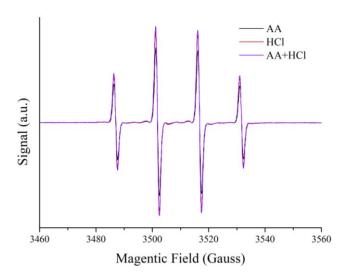


Figure S5. EPR results for PVG medium of Sn in LS-FI-PVG system: 0.01% (v/v) HCl, or/and 0.8% (v/v) AA.

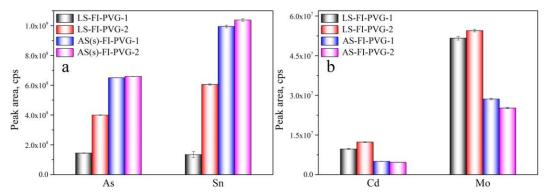


Figure S6. Effect of the internal temperature of PVG reactor on  $^{118}$ Sn,  $^{75}$ As,  $^{111}$ Cd, and  $^{98}$ Mo responses: a) 5 ng mL<sup>-1</sup> As, 4% (v/v) FA, 20% (v/v) AA, 15 mg L<sup>-1</sup> Fe<sup>3+</sup>, and 30 s irradiation; 50 ng mL<sup>-1</sup> Sn, 0.8% (v/v) AA, 0.01% (v/v) HCl, and 32 s irradiation; b) 20 ng mL<sup>-1</sup> Cd, 40% (v/v) FA, 30 mg L<sup>-1</sup> Co<sup>2+</sup>, and 80 s irradiation; 10 ng mL<sup>-1</sup> Mo, 20% (v/v) FA, 20 mg L<sup>-1</sup> Co<sup>2+</sup>, 2.5 mg L<sup>-1</sup> Cu<sup>2+</sup>, and 60 s UV irradiation time.

LS-FI-PVG-1: the blank solution was firstly introduced into the PVG reactor and followed by sample solution as described in the section of Analytical Procedure.

LS-FI-PVG-2: the blank solution was firstly introduced into the PVG reactor and undergone UV irradiation for a while (with the total UV irradiation time of 45 s for As, 25 s for Sn, and 20 s for Cd and Mo) and then sample solution was introduced into the reactor for PVG.

AS(s)-FI-PVG-1: the air slug was firstly injected into the PVG reactor and undergone UV irradiation for a while (with the total UV irradiation time of 45 s for As, 25 s for Sn, and 20 s for Cd and Mo) and then sample solution was introduced into the reactor for PVG.

AS(s)-FI-PVG-2: the air slug was injected continuously into PVG reactor (45 s for As, 25 s for Sn, and 20 s for Cd, Mo) and then sample solution was introduced into the reactor for PVG.

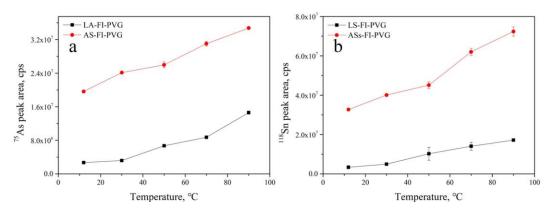
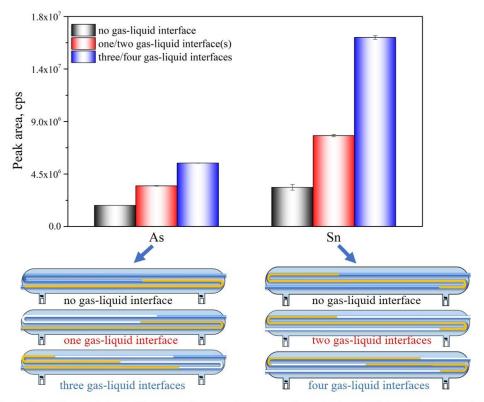


Figure S7. Effect of the sample solution temperature on  $^{75}$ As and  $^{118}$ Sn response in LS-FI-PVG and AS(s)-FI-PVG systems: a) As, 4% (v/v) FA, 20% (v/v) AA, 15 mg L $^{-1}$  Fe $^{3+}$ , and 30 s irradiation; b) Sn, 0.8% (v/v) AA, 0.01% (v/v) HCl, and 32 s irradiation.



Blue color: the PVG medium; yellow color: sample solution; white color: air slug.

Figure S8. Effect of the gas-liquid interfaces on As and Sn detection with 0.3 mL of sample consumption and 0.3 mL of total air-segmented: As, 4% (v/v) FA, 20% (v/v) AA, 15 mg L<sup>-1</sup> Fe<sup>3+</sup>, and 30 s irradiation; Sn, 0.8% (v/v) AA, 0.01% (v/v) HCl, and 32 s irradiation.

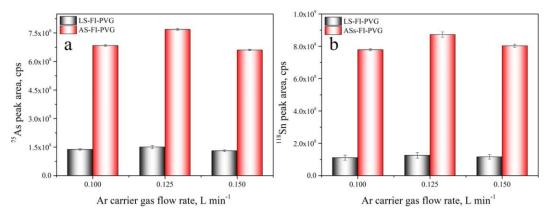


Figure S9. Effect of the Ar carrier gas flow rate on As and Sn responses in PVG. a) As, 4% (v/v) FA, 20% (v/v) AA, 15 mg L<sup>-1</sup> Fe<sup>3+</sup>, and 30 s irradiation; b) Sn, 0.8% (v/v) AA, 0.01% (v/v) HCl, and 32 s irradiation.

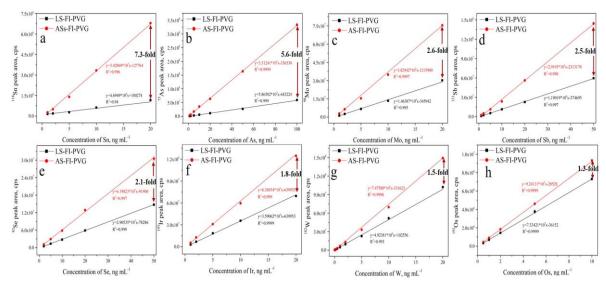


Figure S10. Calibration curves established using LS-FI-PVG and AS(s)-FI-PVG methods for elements: a) Sn, 0.8% (v/v) AA, 0.01% (v/v) HCl, 32 s UV irradiation time in the presence or absence of 1.60 mL air slugs; b) As, 4% (v/v) FA, 20% (v/v) AA, 15 mg L<sup>-1</sup> Fe<sup>3+</sup>, and 30 s irradiation in the presence or absence of 2.88 mL air slug; c) Mo, 30% (v/v) FA, 38 s UV irradiation time in the presence or absence of 1.09 mL air slug; d) Sb, 5% (v/v) FA, 15% (v/v) AA, 60 s UV irradiation time in the presence or absence of 2.24 mL air slug; e) Se (IV), 15% (v/v) FA, 13 s UV irradiation time in the presence or absence of 2.88 mL air slug; f) Ir, 20% (v/v) FA, 25 mg L<sup>-1</sup> Cu<sup>2+</sup>, 45 s UV irradiation time in the presence or absence of 1.60 mL air slug; g) W, 40% (v/v) FA, 500 mg L<sup>-1</sup> Cd<sup>2+</sup>, 120 s UV irradiation time in the presence or absence of 2.24 mL air slug; h) Os, 5% (v/v) HNO<sub>3</sub>, 150 s UV irradiation time in the presence or absence of 0.77 mL air slug.

Table S1. Precision (n=7) obtained using peak area by LS-FI-PVG and AS(s)-FI-PVG methods.

A	RSD %			
Analytes	LS-FI-PVG	AS(s)-FI-PVG		
Sn	8.6	3.0		
As	2.9	1.6		
Bi	2.3	1.5		
Se	3.2	1.1		
Sb	2.6	2.4		
W	3.6	3.0		
Os	2.8	3.3		
Mo	3.7	3.1		
Ir	3.8	2.8		

Table S2. Interferences from coexisting ions obtained in AS(s)-FI-PVG system.

Element	Interfering Concentration ions (mg L <sup>-1</sup> )	[Interferent]/	Recovery/%		
		$(mg L^{-1})$	Analytes	LS-FI-PVG	AS(s)-FI-PVG
As	Co <sup>2+</sup>	0.2	400	127±1	129±2
	$Cu^{2+}$	0.4	800	83±2	76±1
	Ni <sup>2+</sup>	1	2000	106±1	111±1
Bi	Co <sup>2+</sup>	0.02	40	109±1	110±1
Мо	NO <sub>2</sub> -	0.05	100	76±1	73±1
	$NO_3^-$	0.02	40	82±1	91±1
Sn	Fe <sup>3+</sup>	0.05	100	112±3	103±1
	$\mathrm{Co}^{2^+}$	0.02	40	106±2	105±1
	$Ni^{2+}$	0.02	40	104±1	106±1
	$Cu^{2+}$	0.02	40	27±2	46±1